



# TEST REPORT

**Reference No.** : WTX23X02013065W003  
**Manufacturer** : Mid Ocean Brands B.V.  
**Address** : 7/F., Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong  
**Factory** : 103221  
**Product Name** : Desktop charger fan with light  
**Model No.** : MO6810  
**Standards** : ETSI EN 301 489-1 V2.2.3 (2019-11)  
ETSI EN 301 489-3 V2.1.1 (2019-03)  
**Date of Receipt sample** : 2023-02-06  
**Date of Test** : 2023-02-06 to 2023-02-18  
**Date of Issue** : 2023-02-18  
**Test Report Form No.** : WTX\_ESI EN 301 489\_1\_2019W  
**Test Result** : Pass

**Remarks:**

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

**Prepared By:**

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## Report version

Version No.	Date of issue	Description
Rev.00	2023-02-18	Original
/	/	/

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## 1. GENERAL INFORMATION

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### 1.1 Product Description for Equipment Under Test (EUT)

<b>General Description of EUT</b>	
Product Name:	Desktop charger fan with light
Trade Name:	/
Model No.:	MO6810
Adding Model(s):	/
Rated Voltage:	Input: DC 5V-2A;; DC 9V-1.1A
Software Version:	/
Hardware Version:	V0.1

*Note: The test data is gathered from a production sample, provided by the manufacturer.*

<b>Technical Characteristics of EUT</b>	
<b>EN 303417</b>	
Frequency Range:	100-205kHz
Radiated H-Field:	31.90dBuA/m(@3m)
Type of Antenna:	Coil Antenna
Rate Power:	Wireless Output: 10W Max.

*Note: The Antenna Gain is provided by the customer and can affect the validity of results.*



## 1.2 Test Standards

The tests were performed according to following standards:

**ETSI EN 301 489-1 V2.2.3 (2019-11)**: Electromagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements; Harmonised Standard for Electromagnetic Compatibility.

**ETSI EN 301 489-3 V2.1.1 (2019-03)**: Electromagnetic Compatibility (EMC) standard for radio equipment and services; Part 3: Specific conditions for Short-Range Devices (SRD) operating on frequencies between 9 kHz and 246 GHz; Harmonised Standard covering the essential requirements of article 3.1(b) of Directive 2014/53/EU.

**Maintenance of compliance** is the responsibility of the manufacturer. Any modification of the product maybe which result in lowering the emission/immunity should be checked to ensure compliance has been maintained.

## 1.3 Test Methodology

All measurements contained in this report were conducted with the standard ETSI EN 301489-1, Electromagnetic compatibility and Radio spectrum Matters (ERM); Electromagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements.

## 1.4 Test Facility

### Address of the test laboratory

Laboratory: Waltek Testing Group (Shenzhen) Co., Ltd.

Address: 1/F., Room 101, Building 1, Hongwei Industrial Park, Liuxian 2nd Road, Block 70 Bao'an District, Shenzhen, Guangdong, China

### FCC – Registration No.: 125990

Waltek Testing Group (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. The Designation Number is CN5010, and Test Firm Registration Number is 125990.

### Industry Canada (IC) Registration No.: 11464A

The 3m Semi-anechoic chamber of Waltek Testing Group (Shenzhen) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 11464A.



## 1.5 EUT Setup and Operation Mode

The equipment under test (EUT) was configured to measure its highest possible emission/immunity level. The test modes were adapted according to the operation manual for use, more detailed description as follows:

<b>Test Mode List</b>			
Test Mode	Description	Remark	
TM1	Wireless Charging	Connect to the adapter; AC230V/50Hz for adapter; Wireless charging: output 5W	
TM2	Wireless Charging	Connect to the adapter; AC230V/50Hz for adapter; Wireless charging: output 10W	
TM3	Wireless Charging	TT,CT for EMS testing	

<b>EUT Cable List and Details</b>			
Cable Description	Length (m)	Shielded/Unshielded	With / Without Ferrite
USB Cable	1.00	Unshielded	Without Ferrite

<b>Special Cable List and Details</b>			
Cable Description	Length (m)	Shielded/Unshielded	With / Without Ferrite
/	/	/	/

<b>Auxiliary Equipment List and Details</b>			
Description	Manufacturer	Model	Serial Number
wireless charging tester	YBZ	YBZ wireless charging tester	/
Adapter	Xiaomi	MDY-08-ES	/



## 1.6 Performance Criteria for EMS

- EN 301 489-3, The performance criteria are:

In the table below:

- performance criterion A applies for immunity tests with phenomena of a continuous nature;
- performance criterion B applies for immunity tests with phenomena of a transient nature.

NOTE: Whether a phenomenon is considered transient, continuous or otherwise is indicated in the test procedures for the phenomenon in ETSI EN 301 489-1 [1], clause 9.

Table 2: Performance Requirements

Criterion	During test	After test
A	Operate as intended No loss of function No unintentional responses	Operate as intended No loss of function No degradation of performance No loss of stored data or user programmable functions
B	May show loss of function No unintentional responses	Operate as intended Lost function(s) shall be self-recoverable No degradation of performance No loss of stored data or user programmable functions

Where "operate as intended" or "no loss of function" is specified, the EUT shall demonstrate correct functioning as described in ETSI EN 301 489-3 [1], clause 5.

Where the EUT has more than one mode of operation (see clause 4.5.2), an unplanned transition from one mode to another is considered as an unintentional response. The EUT shall be tested in sufficient modes to confirm there are no such unintentional responses.



## 1.7 Measurement Uncertainty

<b>Measurement uncertainty</b>	
<b>Parameter</b>	<b>Uncertainty</b>
Uncertainty for Radiated Emission in 3m chamber	@ 30-200MHz $\pm 4.52\text{dB}$ @ 0.2-1GHz $\pm 5.56\text{dB}$ @ 1-6GHz $\pm 3.84\text{dB}$ @ 6-18GHz $\pm 3.92\text{dB}$
Uncertainty for Conducted Emission	@ 9-150kHz $\pm 3.74\text{dB}$ @ 0.15-30MHz $\pm 3.34\text{dB}$
Uncertainty for Harmonic test	3.26%
Uncertainty for Flicker test	4.76%
Uncertainty for RS test	21%, k=2
Uncertainty for CS test	29%, k=2
Uncertainty for ESD test	The immunity measurement system uncertainty is within standard requirement and is based on a standard uncertainty multiplied by a coverage factor k=2, providing a level of confidence of approximately 95%.
Uncertainty for EFT test	
Uncertainty for Surges test	
Uncertainty for Voltage Dips, Voltage Variations and Short Interruptions Test	
Uncertainty for PFMF test	



## 1.8 Test Equipment List and Details

Description	Manufacturer	Model	Serial Number	Cal Date	Due Date
<input checked="" type="checkbox"/> Chamber A: Below 1GHz					
Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/035	2022-03-22	2023-03-21
EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2022-03-22	2023-03-21
Amplifier	HP	8447F	2805A03475	2022-12-30	2023-12-29
Loop Antenna	Schwarzbeck	FMZB 1516	9773	2021-03-20	2023-03-19
Trilog Broadband Antenna	Schwarzbeck	VULB9163	9163-333	2021-03-20	2023-03-19
<input checked="" type="checkbox"/> Chamber A: Above 1GHz					
Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/035	2022-03-22	2023-03-21
Spectrum Analyzer	Rohde & Schwarz	FSP40	100612	2022-03-22	2023-03-21
EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2022-03-22	2023-03-21
Amplifier	C&D	PAP-1G18	2002	2022-03-22	2023-03-21
Horn Antenna	ETS	3117	00086197	2021-03-19	2023-03-18
Horn Antenna	Schwarzbeck	BBHA 9170	BBHA9170582	2021-04-27	2023-04-26
Pre-amplifier	Schwarzbeck	BBV 9721	9721-031	2022-03-25	2023-03-24
<input type="checkbox"/> Chamber B: Below 1GHz					
Trilog Broadband Antenna	Schwarzbeck	VULB9163(B)	9163-635	2021-04-09	2023-04-08
Amplifier	Agilent	8447D	2944A10179	2022-03-22	2023-03-21
EMI Test Receiver	Rohde & Schwarz	ESPI	101391	2022-03-25	2023-03-24
<input type="checkbox"/> Chamber C: Below 1GHz					
EMI Test Receiver	Rohde & Schwarz	ESIB 26	100401	2022-12-30	2023-12-29
Trilog Broadband Antenna	Schwarzbeck	VULB 9168	1194	2021-05-28	2023-05-27
Amplifier	HP	8447F	2944A03869	2022-03-22	2023-03-21
<input checked="" type="checkbox"/> Conducted Room 1#					
EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2022-03-22	2023-03-21
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2022-03-25	2023-03-24
AC LISN	Schwarzbeck	NSLK8126	8126-224	2022-03-22	2023-03-21
8-WIRE LISN	Schwarzbeck	8158	CAT3-8158-0059	2022-03-22	2023-03-21
8-WIRE LISN	Schwarzbeck	8158	CAT5-8158-0117	2022-03-22	2023-03-21
<input type="checkbox"/> Conducted Room 2#					
EMI Test Receiver	Rohde & Schwarz	ESPI	10129	2022-03-22	2023-03-21
LISN	Rohde & Schwarz	ENV 216	100097	2022-03-22	2023-03-21
<input type="checkbox"/> EMF					
VDH Test Head	AFJ	VDH 30	SC022Z	2022-03-25	2023-03-24
<input type="checkbox"/> 3 Loop Antenna					
Loop Antenna	ZHINAN	ZN30401	19037	2021-04-26	2023-04-25



Clamp					
Clamp	Luthi	MDS21	3809	2022-03-28	2023-03-27
PFMF					
PMF Generator	LIONCEL	PMF-801C-C	0171101	2022-03-22	2023-03-21
PMF Antenna	LIONCEL	PMF-801C-A	0180302	2022-03-22	2023-03-21
Instantaneous PMF Generator Module	LIONCEL	PMF-801C-T	0171001	2022-03-22	2023-03-21
H/F					
Digital Power Analyzer	California Instrument	CTS	72831	2022-03-22	2023-03-21
Power Source	California Instrument	5001IX-CTS-400	25965	2022-03-22	2023-03-21
ESD					
ESD Generator	LIONCEL	ESD-203B	0170901	2022-03-28	2023-03-27
EFT/SURGE/DIPS					
Transient 2000	EMC PARTNER	TRA2000	863	2022-03-22	2023-03-21
Couple Clamp	EMC PARTNER	CN-EFT1000	513	2022-03-22	2023-03-21
CS					
CONDUCTED IMMUNITY TEST SYSTEM	FRANKONIA	CIT-10/75	126B1247/2013	2022-12-30	2023-12-29
Attenuator	EMTEST	MA-5100/6BF2	1009	2022-03-22	2023-03-21
CDN	Luthi	L-801M2/M3	2665	2022-03-22	2023-03-21
CDN	LIONCEL	CDN-T8	0210401	2022-03-25	2023-03-24
EM Clamp	TESEQ	KEMZ801A	45028	2022-03-25	2023-03-24
RS					
Signal Generator	HP	8688B	3438A00604	2022-03-22	2023-03-21
Power Meter	KEITHLEY	3500	1162591	2022-03-22	2023-03-21
Power Meter	KEITHLEY	3500	1121428	2022-03-22	2023-03-21
RF Power Amplifier	MicoTop	MPA-80-1000-25 0	MPA1906239	2022-03-22	2023-03-21
RF Power Amplifier	MicoTop	MPA-80-6000-10 0	MPA1906238	2022-03-22	2023-03-21
Antenna	SCHWARZBECK	STLP 9129	9129 114	N/A	N/A
Power Meter	Agilent	E4419B	GB42420578	2022-03-22	2023-03-21



<b>Software List</b>			
Description	Manufacturer	Model	Version
EMI Test Software (Radiated Emission)*	Farad	EZ-EMC	RA-03A1
EMI Test Software (Conducted Emission)*	Farad	EZ-EMC	RA-03A1

\*Remark: indicates software version used in the compliance certification testing.

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## 2. SUMMARY OF TEST RESULTS

Standards	Reference	Description of Test Item	Result
ETSI EN 301 489-1	8.2	Radiated Emissions	Pass
	8.3	Conducted Emissions for DC Power Port	N/A
	8.4	Conducted Emissions for AC Power Port	Pass
	8.5	Harmonic Current Emissions	Pass
	8.6	Voltage Fluctuations and Flicker	Pass
	8.7	Telecommunication Ports	N/A
	9.2	Radio Frequency Electromagnetic Field	Pass
	9.3	Electrostatic Discharge	Pass
	9.4	Fast Transients, Common Mode	Pass
	9.5	Radio Frequency, Common Mode	Pass
	9.6	Transient and Surges in the Vehicular Environment	N/A
	9.7	Voltage Dips and Interruptions	Pass
	9.8	Surges	Pass
Pass: The EUT complies with the essential requirements in the standard. Fail: The EUT does not comply with the essential requirements in the standard. N/A: Not applicable.			

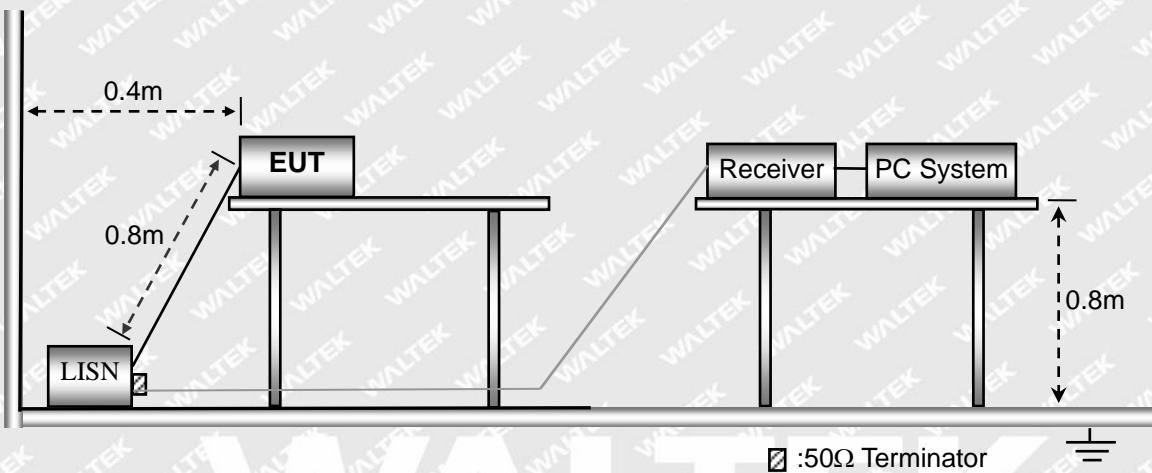


### 3. Conducted Emissions

#### 3.1 Test Procedure

Test is conducting under the description of EN55032 Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement.

#### 3.2 Basic Test Setup Block Diagram

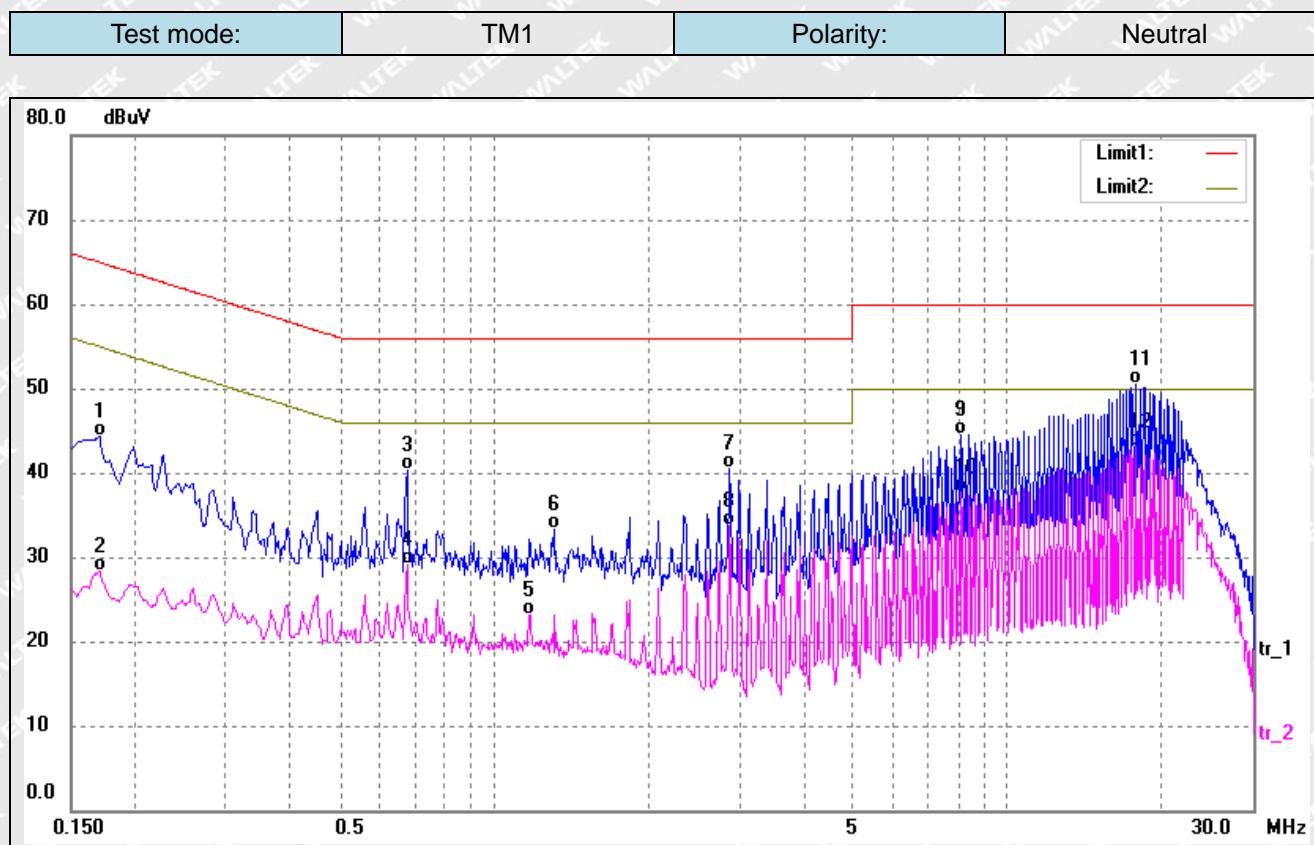


#### 3.3 Environmental Conditions

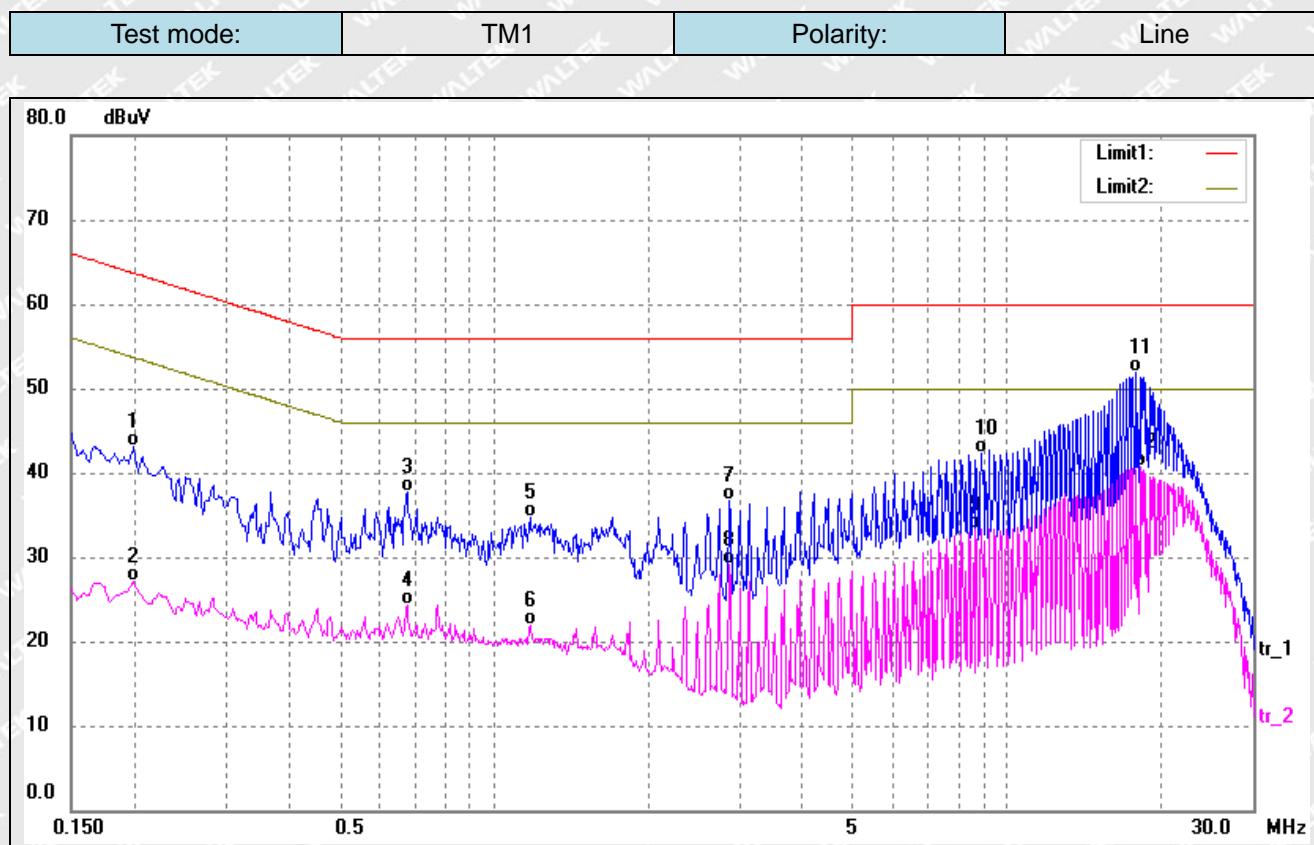
Temperature:	23.5 ° C
Relative Humidity:	54%
ATM Pressure:	1015 mbar

#### 3.4 Conducted Emissions Test Data

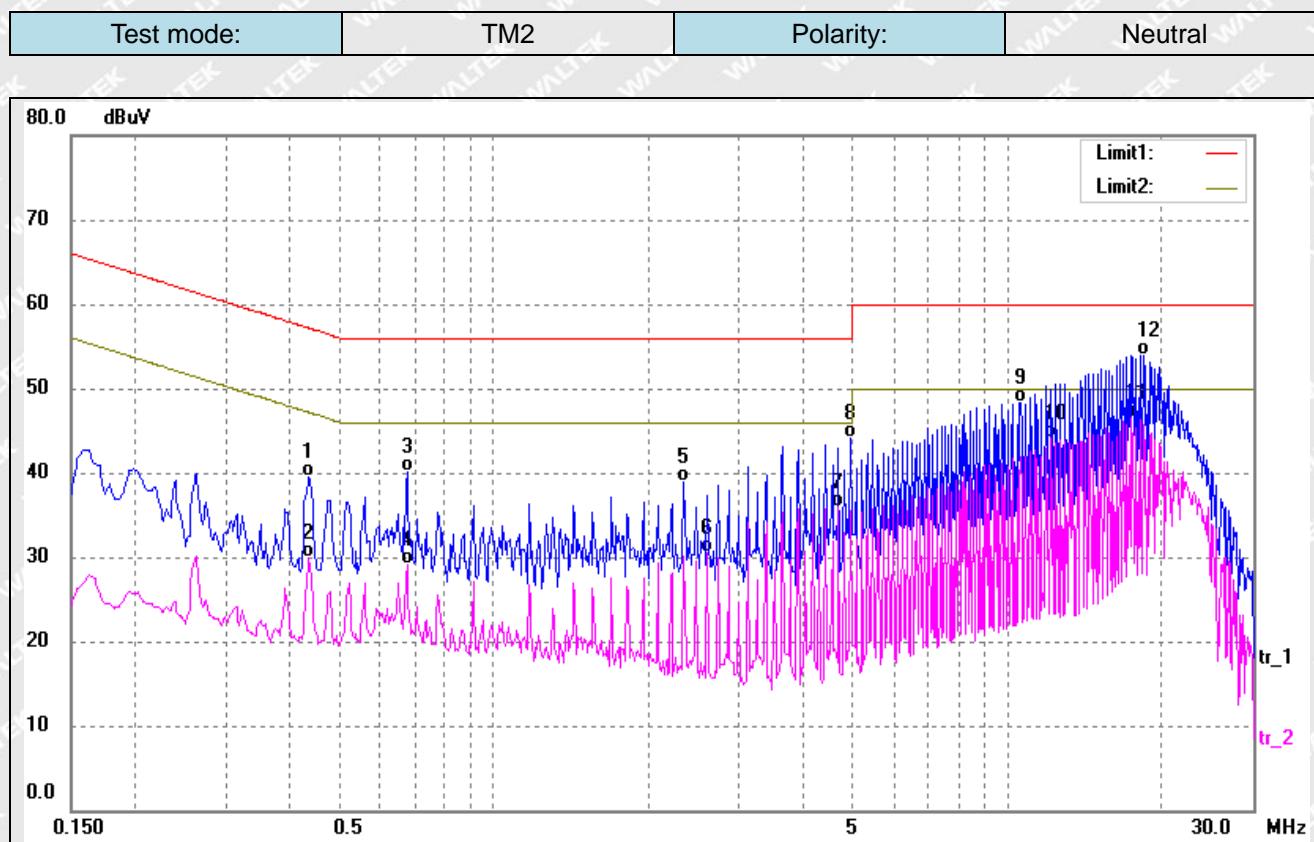
Note: Only show the worst case in the test report.



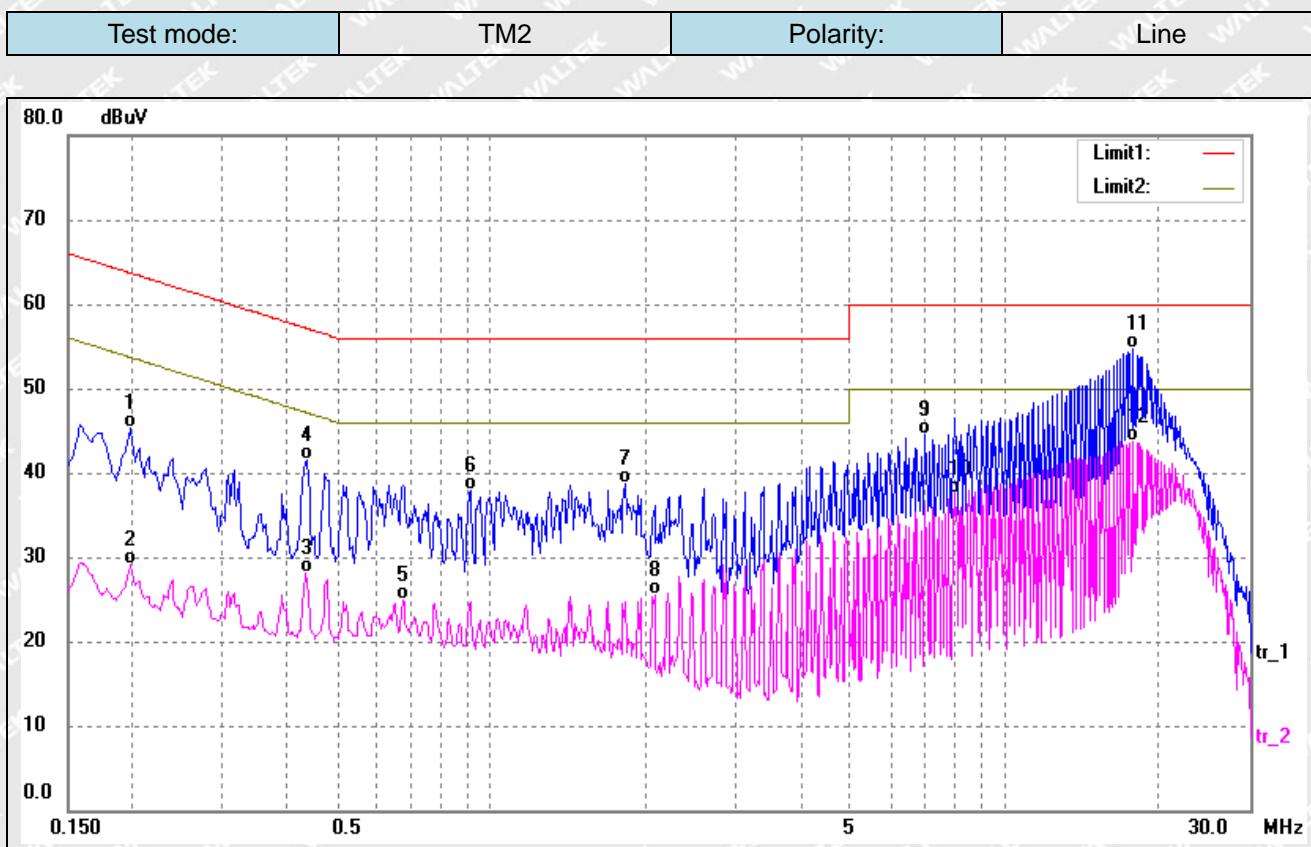
No.	Frequency (MHz)	Reading (dB <sub>uV</sub> )	Correct (dB)	Result (dB <sub>uV</sub> )	Limit (dB <sub>uV</sub> )	Margin (dB)	Detector
1	0.1700	33.96	10.31	44.27	64.96	-20.69	QP
2	0.1700	18.02	10.31	28.33	54.96	-26.63	AVG
3	0.6780	30.12	10.20	40.32	56.00	-15.68	QP
4	0.6780	18.94	10.20	29.14	46.00	-16.86	AVG
5	1.1780	12.98	10.16	23.14	46.00	-22.86	AVG
6	1.3099	23.17	10.17	33.34	56.00	-22.66	QP
7	2.8820	30.24	10.27	40.51	56.00	-15.49	QP
8	2.8820	23.50	10.27	33.77	46.00	-12.23	AVG
9	8.1220	34.23	10.34	44.57	60.00	-15.43	QP
10	8.1220	27.39	10.34	37.73	50.00	-12.27	AVG
11	17.8140	40.12	10.32	50.44	60.00	-9.56	QP
12*	17.8140	32.72	10.32	43.04	50.00	-6.96	AVG



No.	Frequency (MHz)	Reading (dBuV)	Correct (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector
1	0.1980	32.77	10.30	43.07	63.69	-20.62	QP
2	0.1980	16.83	10.30	27.13	53.69	-26.56	AVG
3	0.6780	27.50	10.20	37.70	56.00	-18.30	QP
4	0.6780	14.12	10.20	24.32	46.00	-21.68	AVG
5	1.1780	24.60	10.16	34.76	56.00	-21.24	QP
6	1.1780	11.75	10.16	21.91	46.00	-24.09	AVG
7	2.8820	26.49	10.27	36.76	56.00	-19.24	QP
8	2.8820	18.77	10.27	29.04	46.00	-16.96	AVG
9	8.6500	22.93	10.34	33.27	50.00	-16.73	AVG
10	8.9100	32.01	10.35	42.36	60.00	-17.64	QP
11*	17.8180	41.56	10.32	51.88	60.00	-8.12	QP
12	18.0820	30.30	10.32	40.62	50.00	-9.38	AVG



No.	Frequency (MHz)	Reading (dB <sub>uV</sub> )	Correct (dB)	Result (dB <sub>uV</sub> )	Limit (dB <sub>uV</sub> )	Margin (dB)	Detector
1	0.4340	29.29	10.23	39.52	57.18	-17.66	QP
2	0.4340	19.61	10.23	29.84	47.18	-17.34	AVG
3	0.6780	29.87	10.20	40.07	56.00	-15.93	QP
4	0.6780	18.84	10.20	29.04	46.00	-16.96	AVG
5	2.3420	28.72	10.26	38.98	56.00	-17.02	QP
6	2.6020	20.27	10.27	30.54	46.00	-15.46	AVG
7	4.6820	25.51	10.32	35.83	46.00	-10.17	AVG
8	4.9420	33.72	10.33	44.05	56.00	-11.95	QP
9	10.5780	37.98	10.34	48.32	60.00	-11.68	QP
10	12.1260	33.76	10.31	44.07	50.00	-5.93	AVG
11*	17.2979	36.18	10.30	46.48	50.00	-3.52	AVG
12	18.3380	43.63	10.33	53.96	60.00	-6.04	QP



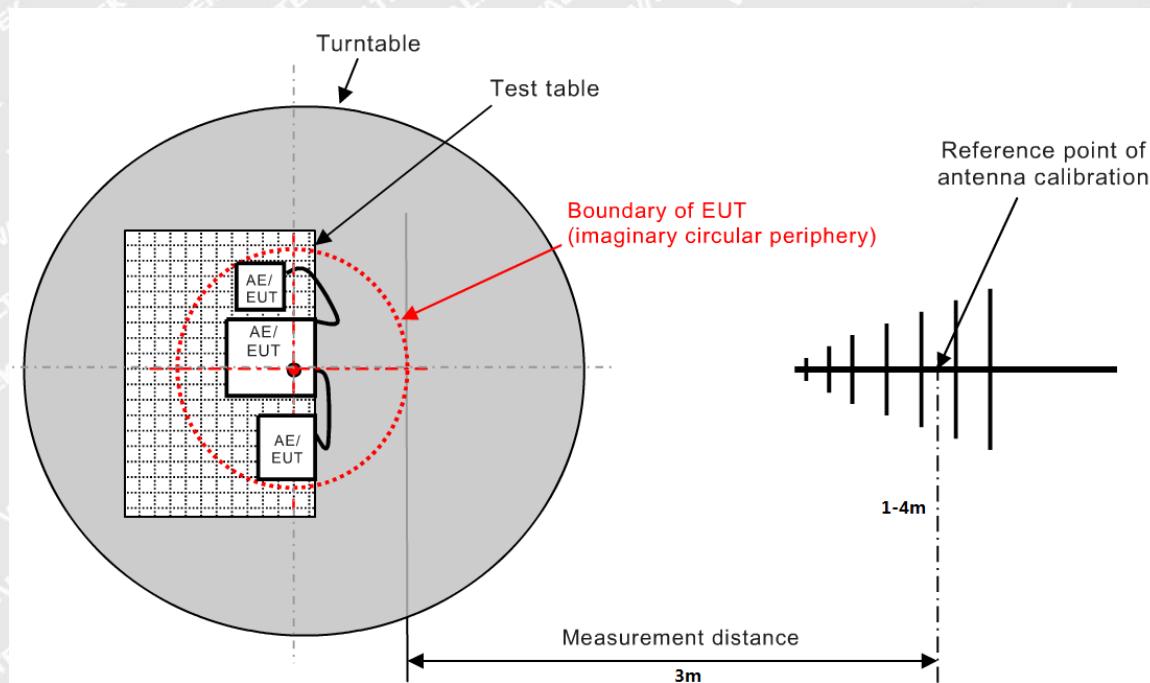
No.	Frequency (MHz)	Reading (dB <sub>uV</sub> )	Correct (dB)	Result (dB <sub>uV</sub> )	Limit (dB <sub>uV</sub> )	Margin (dB)	Detector
1	0.1980	34.96	10.30	45.26	63.69	-18.43	QP
2	0.1980	18.78	10.30	29.08	53.69	-24.61	AVG
3	0.4340	17.94	10.23	28.17	47.18	-19.01	AVG
4	0.4380	31.22	10.23	41.45	57.10	-15.65	QP
5	0.6740	14.61	10.20	24.81	46.00	-21.19	AVG
6	0.9100	27.78	10.15	37.93	56.00	-18.07	QP
7	1.8220	28.42	10.23	38.65	56.00	-17.35	QP
8	2.0820	15.25	10.25	25.50	46.00	-20.50	AVG
9	6.9660	34.23	10.34	44.57	60.00	-15.43	QP
10	7.9980	27.12	10.34	37.46	50.00	-12.54	AVG
11*	17.8020	44.41	10.32	54.73	60.00	-5.27	QP
12	17.8020	33.45	10.32	43.77	50.00	-6.23	AVG



## 4. Radiated Emissions

### 4.2 Test Procedure

Test is conducting under the description of EN55032 Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement.



### 4.2 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} + \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain}$$

The “Margin” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -6dB $\mu$ V means the emission is 6dB $\mu$ V below the maximum limit for Class B device. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{EN 301489 Class B Limit}$$



### 4.3 Environmental Conditions

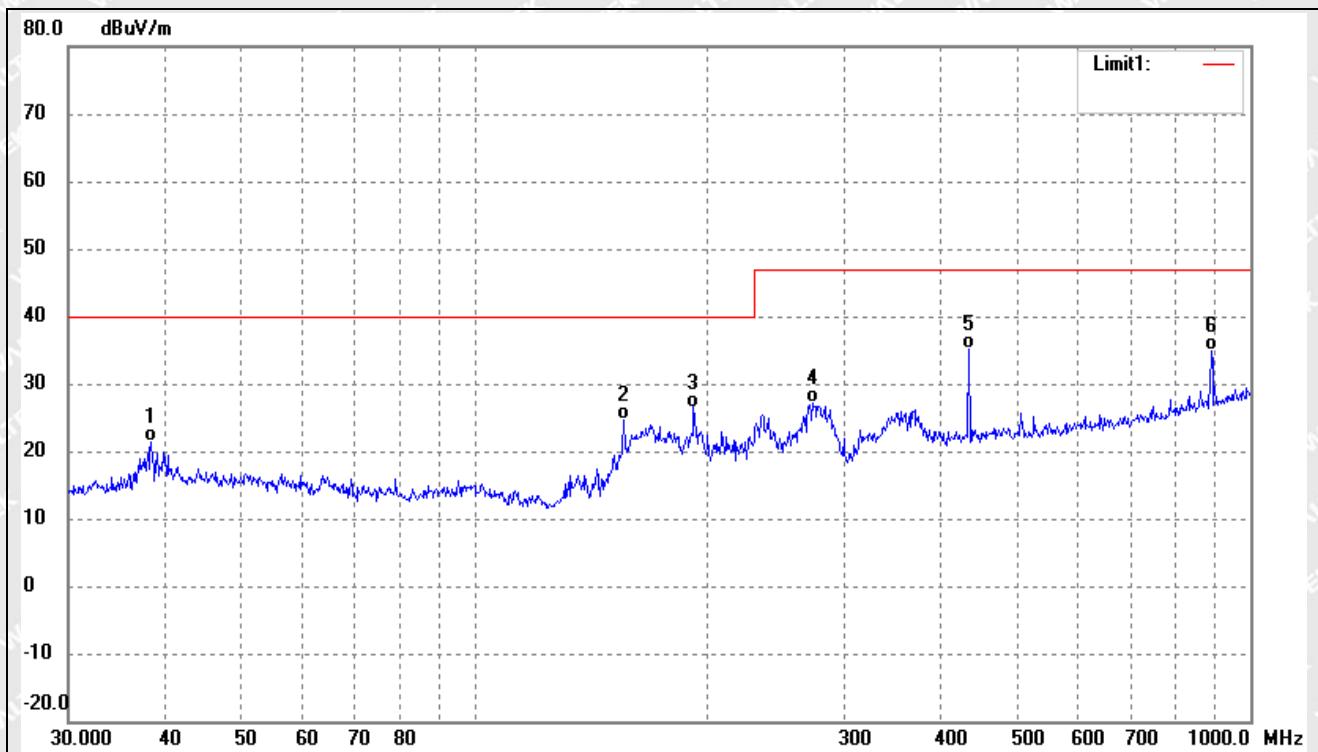
Temperature:	23.5° C
Relative Humidity:	54%
ATM Pressure:	1011 mbar

### 4.4 Summary of Test Results/Plots

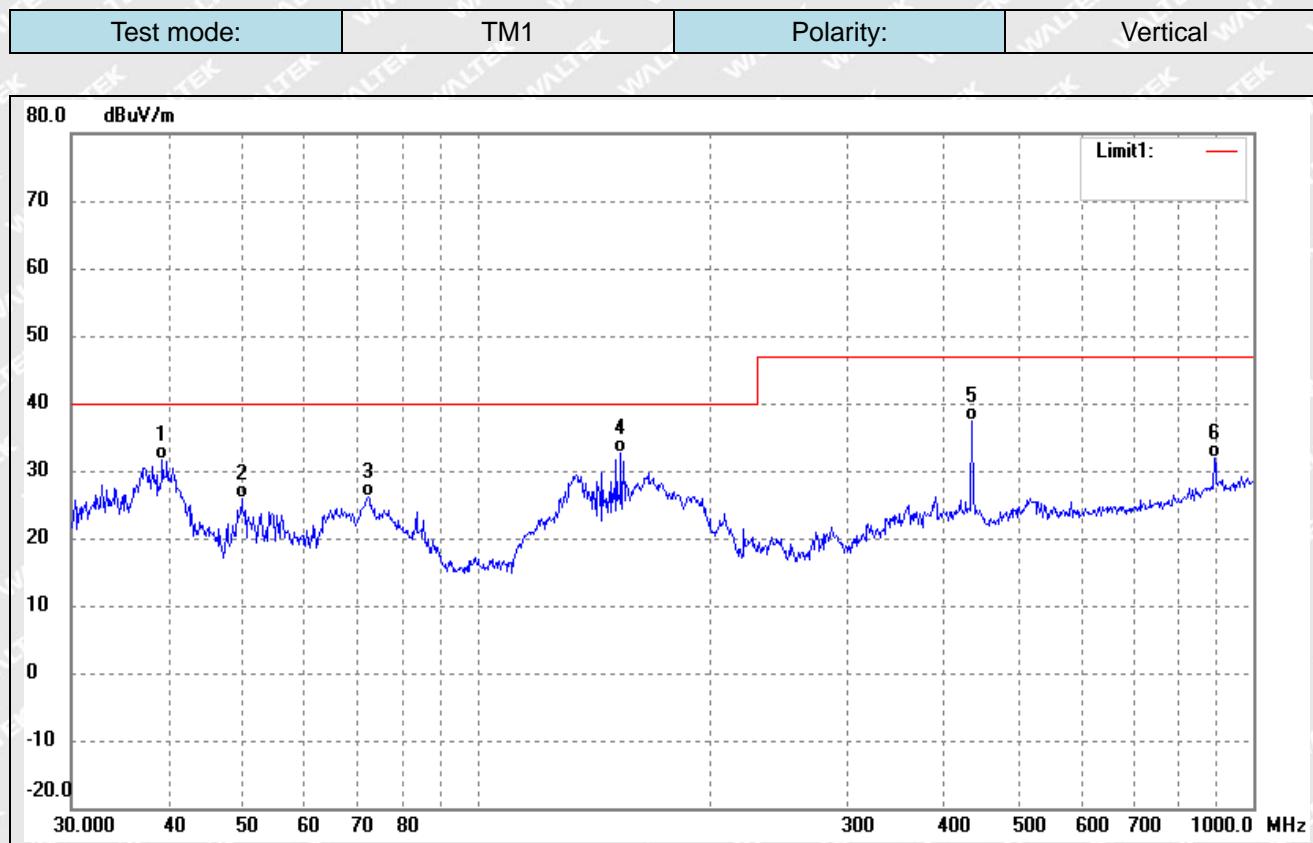
Note: Only show the worst case in the test report

➤ 30MHz to 1GHz

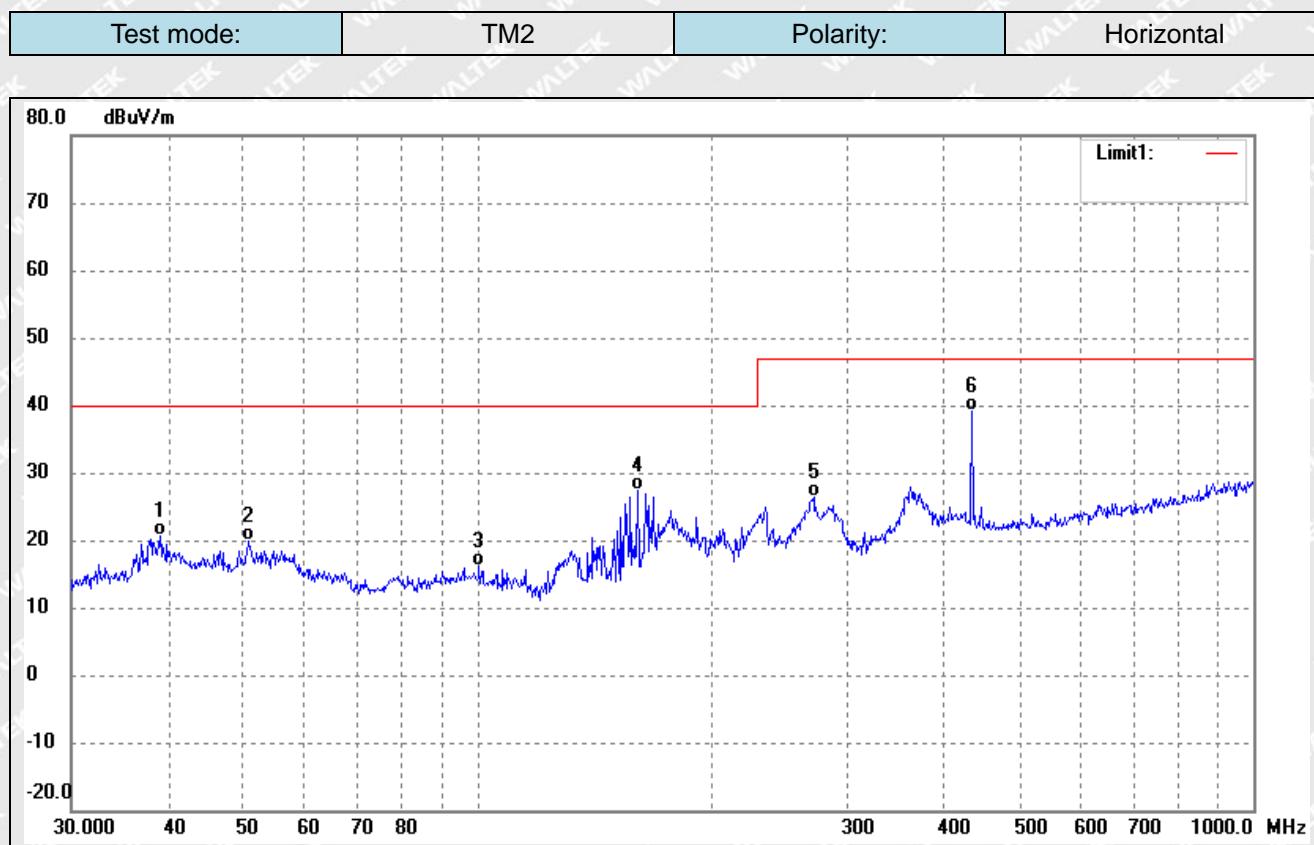
Test mode:	TM1	Polarity:	Horizontal
------------	-----	-----------	------------



No.	Frequency (MHz)	Reading (dBuV/m)	Correct dB/m	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree ( )	Height (cm)	Remark
1	38.3462	32.47	-11.20	21.27	40.00	-18.73	-	-	QP
2	155.9101	39.73	-15.01	24.72	40.00	-15.28	-	-	QP
3	191.7450	39.24	-12.74	26.50	40.00	-13.50	-	-	QP
4	273.2341	37.37	-10.16	27.21	47.00	-19.79	-	-	QP
5	434.0651	40.44	-5.39	35.05	47.00	-11.95	-	-	QP
6	890.7278	34.57	0.30	34.87	47.00	-12.13	-	-	QP



No.	Frequency (MHz)	Reading (dB $\mu$ V/m)	Correct dB/m	Result (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)	Degree ( )	Height (cm)	Remark
1	39.2991	42.68	-11.04	31.64	40.00	-8.36	-	-	QP
2	49.7068	36.68	-10.89	25.79	40.00	-14.21	-	-	QP
3	72.3376	41.43	-15.34	26.09	40.00	-13.91	-	-	QP
4	153.2004	47.88	-15.14	32.74	40.00	-7.26	-	-	QP
5	434.0651	42.83	-5.39	37.44	47.00	-9.56	-	-	QP
6	890.7278	31.56	0.30	31.86	47.00	-15.14	-	-	QP



No.	Frequency (MHz)	Reading (dB $\mu$ V/m)	Correct dB/m	Result (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)	Degree	Height (cm)	Remark
1	39.0245	31.70	-11.09	20.61	40.00	-19.39	-	-	QP
2	50.7637	30.85	-11.04	19.81	40.00	-20.19	-	-	QP
3	100.5806	28.21	-12.11	16.10	40.00	-23.90	-	-	QP
4	160.9089	42.26	-14.78	27.48	40.00	-12.52	-	-	QP
5	271.3246	36.54	-10.23	26.31	47.00	-20.69	-	-	QP
6	434.0651	44.46	-5.39	39.07	47.00	-7.93	-	-	QP



Test mode:

TM2

Polarity:

Vertical



No.	Frequency (MHz)	Reading (dB $\mu$ V/m)	Correct dB/m	Result (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)	Degree ( )	Height (cm)	Remark
1	38.4809	44.48	-11.17	33.31	40.00	-6.69	-	-	QP
2	55.4147	40.47	-11.93	28.54	40.00	-11.46	-	-	QP
3	67.2022	39.81	-14.64	25.17	40.00	-14.83	-	-	QP
4	164.9075	50.74	-14.61	36.13	40.00	-3.87	-	-	QP
5	290.0172	32.53	-9.64	22.89	47.00	-24.11	-	-	QP
6	434.0651	46.33	-5.39	40.94	47.00	-6.06	-	-	QP

Remark: '-'Means' the test Degree and Height are not recorded by the test software and only show the worst case in the test report.

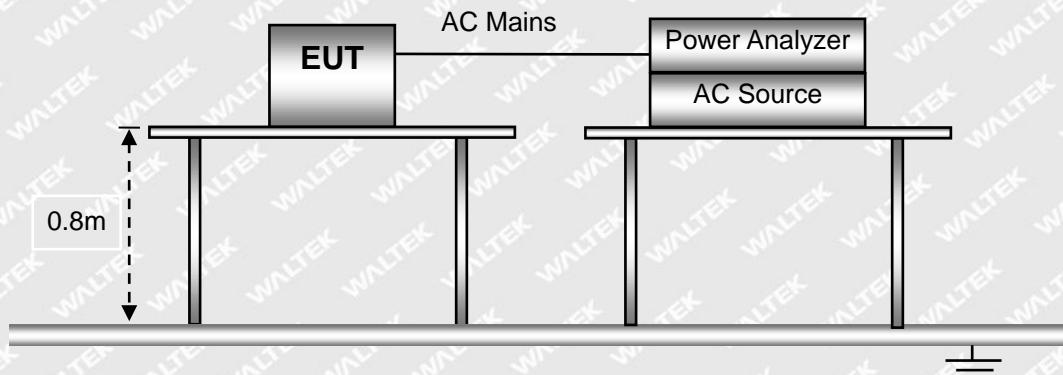


## 5. Harmonic Current Emissions

### 5.1 Test Procedure

Test is conducting under the description of EN 61000-3-2.

### 5.2 Test Setup Block Diagram



### 5.3 Test Standards

EN61000-3-2, Clause 7.1 Limits for Class A equipment.

### 5.4 Environmental Conditions

Temperature:	25°C
Relative Humidity:	50%
ATM Pressure:	1011 mbar

### 5.5 Harmonic Current Emissions Test Data



## Harmonics – Class-A

**Test category: Class-A (European limits)**

**Test Margin: 100**

**Test date: 2023/2/9**

**Start time: 9:33:42**

**End time: 9:36:23**

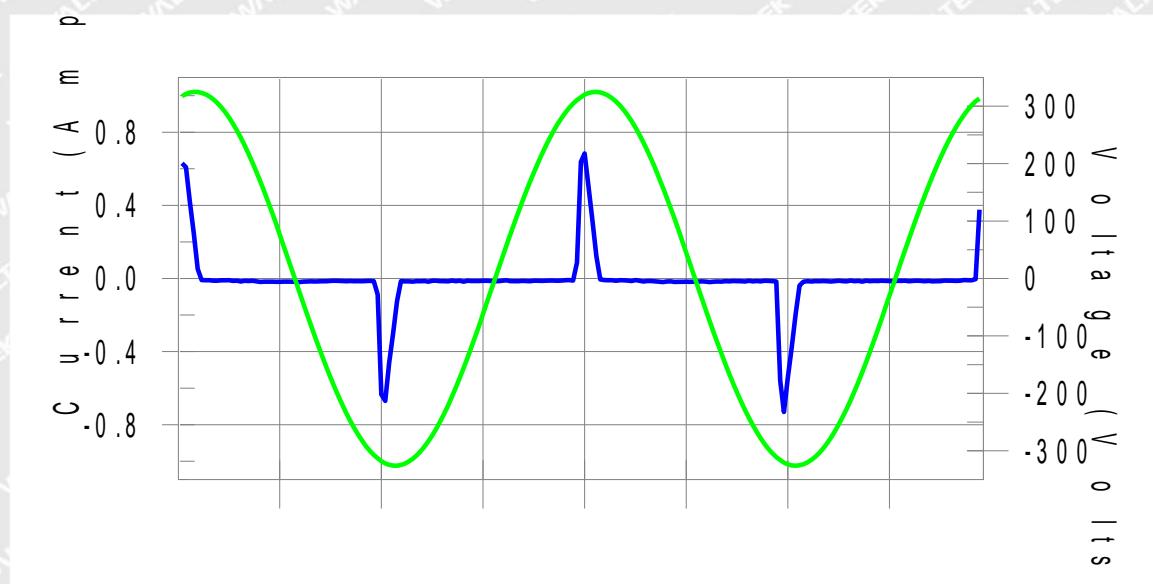
**Test duration (min): 2.5**

**Data file name: H-000298.cts\_data**

**Test Result: Pass**

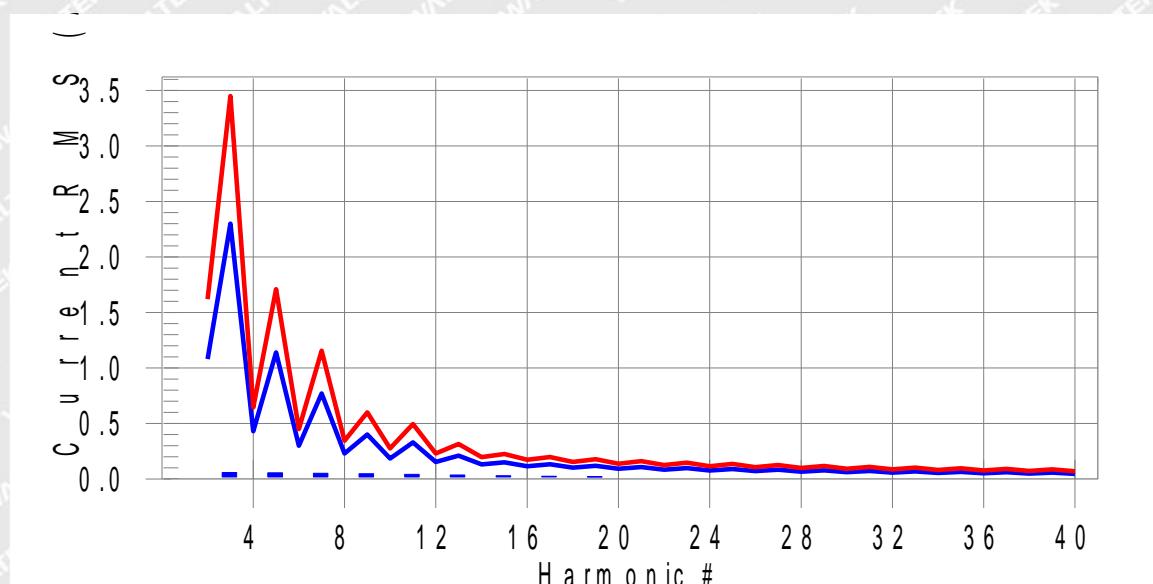
**Source qualification: Normal**

**Current & voltage waveforms**



**Harmonics and Class A limit line**

**European Limits**



**Test result: Pass**

**Worst harmonics H15-13.6% of 150% limit, H15-20.3% of 100% limit**



## Current Test Result Summary (Run time)

**Test category:** Class-A (European limits)

**Test Margin:** 100

**Test date:** 2023/2/9

**Start time:** 9:33:42

**End time:** 9:36:23

**Test duration (min):** 2.5

**Data file name:** H-000298.cts\_data

**Test Result:** Pass

**Source qualification:** Normal

**THC(A):** 0.131

**I-THD(%):** 214.0

**POHC(A):** 0.031

**POHC Limit(A):** 0.251

**Highest parameter values during test:**

<b>V_RMS (Volts):</b>	230.10	<b>Frequency(Hz):</b>	50.00
<b>I_Peak (Amps):</b>	0.735	<b>I_RMS (Amps):</b>	0.150
<b>I_Fund (Amps):</b>	0.061	<b>Crest Factor:</b>	5.074
<b>Power (Watts):</b>	14.0	<b>Power Factor:</b>	0.417

Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.001	1.080	N/A	0.001	1.620	N/A	Pass
3	0.058	2.300	2.5	0.059	3.450	1.7	Pass
4	0.001	0.430	N/A	0.001	0.645	N/A	Pass
5	0.055	1.140	4.8	0.056	1.710	3.3	Pass
6	0.000	0.300	N/A	0.001	0.450	N/A	Pass
7	0.052	0.770	6.7	0.052	1.155	4.5	Pass
8	0.000	0.230	N/A	0.001	0.345	N/A	Pass
9	0.047	0.400	11.7	0.047	0.600	7.9	Pass
10	0.000	0.184	N/A	0.001	0.276	N/A	Pass
11	0.042	0.330	12.6	0.042	0.495	8.5	Pass
12	0.000	0.153	N/A	0.001	0.230	N/A	Pass
13	0.036	0.210	17.2	0.036	0.315	11.6	Pass
14	0.000	0.131	N/A	0.001	0.197	N/A	Pass
15	0.030	0.150	20.3	0.031	0.225	13.6	Pass
16	0.000	0.115	N/A	0.001	0.173	N/A	Pass
17	0.025	0.132	18.9	0.025	0.198	12.7	Pass
18	0.000	0.102	N/A	0.001	0.153	N/A	Pass
19	0.020	0.118	16.8	0.020	0.178	11.3	Pass
20	0.000	0.092	N/A	0.001	0.138	N/A	Pass
21	0.016	0.107	14.7	0.016	0.161	9.9	Pass
22	0.000	0.084	N/A	0.001	0.125	N/A	Pass
23	0.013	0.098	13.0	0.013	0.147	8.7	Pass
24	0.000	0.077	N/A	0.001	0.115	N/A	Pass
25	0.011	0.090	11.9	0.011	0.135	8.1	Pass
26	0.000	0.071	N/A	0.001	0.107	N/A	Pass
27	0.010	0.083	11.7	0.010	0.125	7.9	Pass



28	0.000	0.066	N/A	0.001	0.099	N/A	Pass
29	0.009	0.078	11.9	0.009	0.116	8.1	Pass
30	0.000	0.061	N/A	0.001	0.092	N/A	Pass
31	0.009	0.073	12.2	0.009	0.109	8.3	Pass
32	0.000	0.058	N/A	0.001	0.086	N/A	Pass
33	0.008	0.068	12.2	0.008	0.102	8.3	Pass
34	0.000	0.054	N/A	0.001	0.081	N/A	Pass
35	0.008	0.064	11.8	0.008	0.096	8.0	Pass
36	0.000	0.051	N/A	0.000	0.077	N/A	Pass
37	0.007	0.061	10.9	0.007	0.091	7.4	Pass
38	0.000	0.048	N/A	0.000	0.073	N/A	Pass
39	0.006	0.058	9.7	0.006	0.087	6.6	Pass
40	0.000	0.046	N/A	0.000	0.069	N/A	Pass

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## Voltage Source Verification Data (Run time)

**Test category: Class-A (European limits)**

**Test Margin: 100**

**Test date: 2023/2/9**

**Start time: 9:33:42**

**End time: 9:36:23**

**Test duration (min): 2.5**

**Data file name: H-000298.cts\_data**

**Test Result: Pass**

**Source qualification: Normal**

**Highest parameter values during test:**

Voltage (Vrms):	230.10	Frequency(Hz):	50.00
I_Peak (Amps):	0.735	I_RMS (Amps):	0.150
I_Fund (Amps):	0.061	Crest Factor:	5.074
Power (Watts):	14.0	Power Factor:	0.417

Harm#	Harmonics V-rms	Limit V-rms	% of Limit	Status
2	0.049	0.460	10.64	OK
3	0.508	2.070	24.53	OK
4	0.079	0.460	17.17	OK
5	0.058	0.920	6.29	OK
6	0.034	0.460	7.39	OK
7	0.028	0.690	4.05	OK
8	0.018	0.460	3.85	OK
9	0.030	0.460	6.51	OK
10	0.008	0.460	1.79	OK
11	0.034	0.230	14.64	OK
12	0.010	0.230	4.43	OK
13	0.028	0.230	12.04	OK
14	0.005	0.230	2.24	OK
15	0.031	0.230	13.50	OK
16	0.008	0.230	3.34	OK
17	0.017	0.230	7.22	OK
18	0.010	0.230	4.29	OK
19	0.027	0.230	11.57	OK
20	0.014	0.230	6.15	OK
21	0.020	0.230	8.61	OK
22	0.004	0.230	1.53	OK
23	0.017	0.230	7.22	OK
24	0.003	0.230	1.14	OK
25	0.014	0.230	6.16	OK
26	0.002	0.230	0.90	OK
27	0.018	0.230	7.98	OK
28	0.004	0.230	1.72	OK



29		0.010	0.230	4.44	OK
30		0.004	0.230	1.69	OK
31		0.013	0.230	5.78	OK
32		0.002	0.230	0.96	OK
33		0.013	0.230	5.60	OK
34		0.002	0.230	0.87	OK
35		0.013	0.230	5.60	OK
36		0.002	0.230	0.78	OK
37		0.013	0.230	5.72	OK
38		0.002	0.230	1.00	OK
39		0.014	0.230	5.93	OK
40		0.008	0.230	3.39	OK

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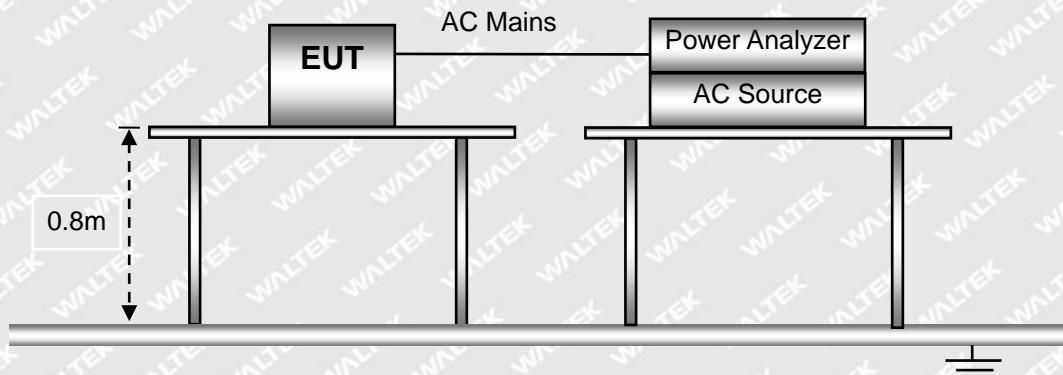


## 6. Voltage Fluctuation and Flicker

### 6.1 Test Procedure

Test is conducting under the description of EN 61000-3-3.

### 6.2 Test Setup Block Diagram



### 6.3 Test Standards

EN61000-3-3, Limit: Clause 5.

### 6.4 Environmental Conditions

Temperature:	25°C
Relative Humidity:	50%
ATM Pressure:	1011 mbar

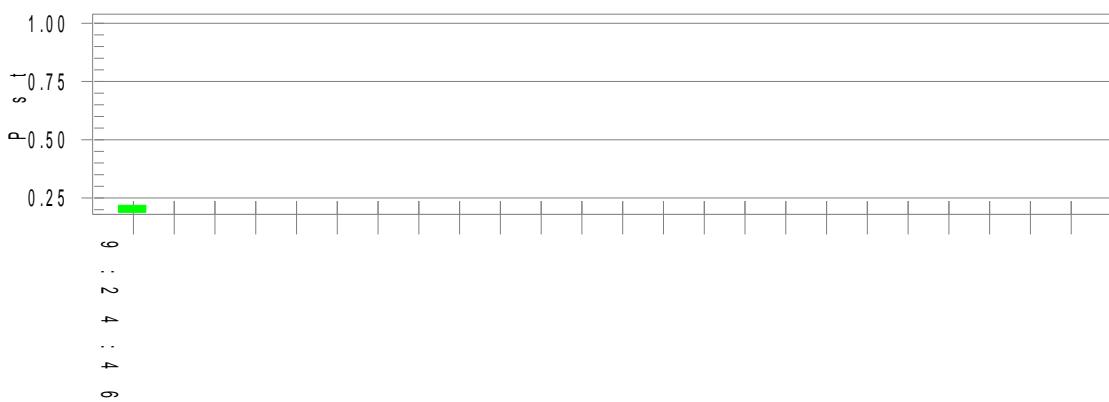
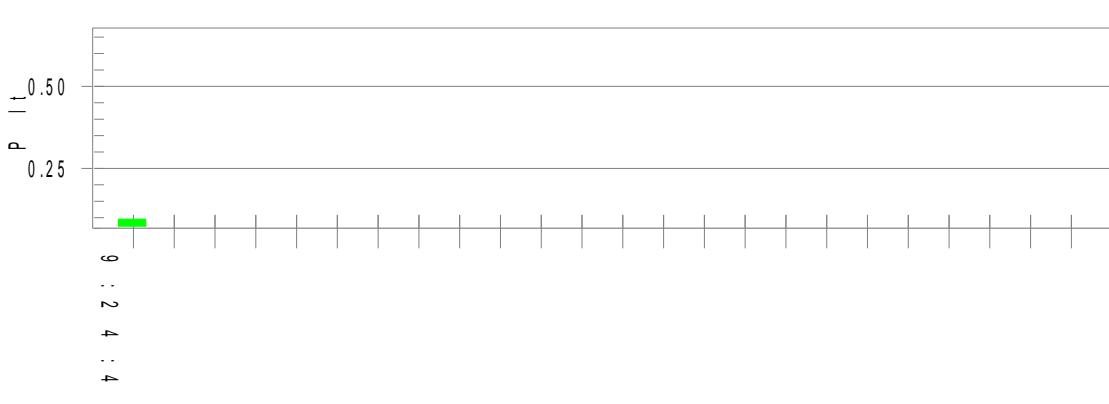
### 6.5 Voltage Fluctuation and Flicker Test Data

Result: The EUT is compliance with the requirements of this section.



Test mode:

TM1

**Test Result: Pass****Status: Test Completed****Pst<sub>i</sub> and limit line****European Limits****Plt and limit line****Parameter values recorded during the test:**

Vrms at the end of test (Volt): 230.08

**Highest dt (%):**

T-max (mS):	0	Test limit (%):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	0.00	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.219	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.096	Test limit:	0.650	Pass

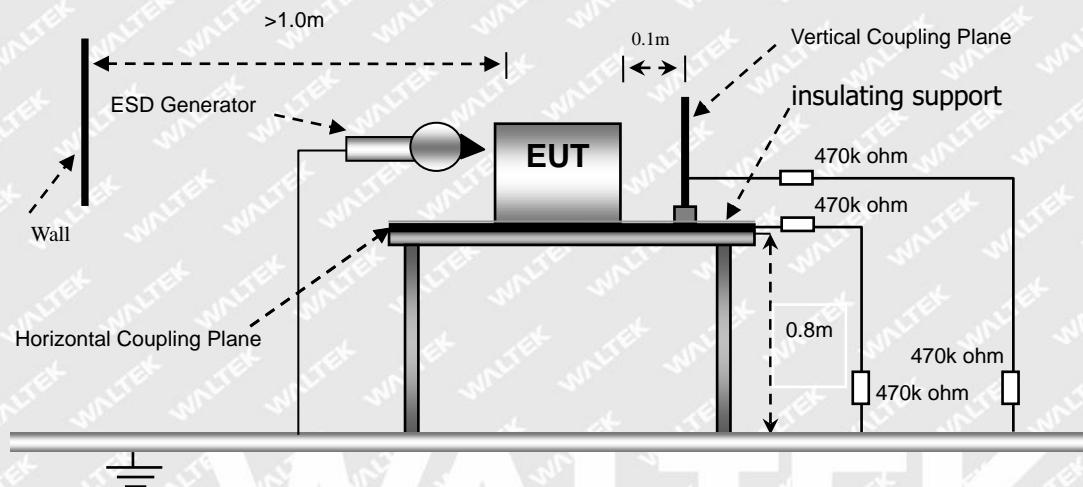


## 7. Electrostatic Discharge (ESD)

### 7.1 Test Procedure

Test is conducting under the description of EN 61000-4-2.

### 7.2 Test Setup Block Diagram



### 7.3 Test Performance

Performance Criterion:	Mode	Verdict
	TM1-TM3	B

Note: TM3 for TT,TR

### 7.4 Environmental Conditions

Temperature:	25°C
Relative Humidity:	50%
ATM Pressure:	1011 mbar

### 7.5 Electrostatic Discharge Immunity Test Data



Test mode	TM1-TM3							
EN 61000-4-2 Test Points	Test Levels (kV)							
	-2	+2	-4	+4	-6	+6	-8	+8
Air Discharge								
USB Port	A	A	A	A	A	A	B	B
Button	A	A	A	A	A	A	B	B
Enclosure	A	A	A	A	A	A	B	B
Direct Contact Discharge								
USB Port	A	A	A	A	/	/	/	/
Enclosure	A	A	A	A	/	/	/	/
Indirect Contact Discharge								
HCP (6 Sides)	A	A	A	A	/	/	/	/
VCP (4 Sides)	A	A	A	A	/	/	/	/

Test Result: Pass

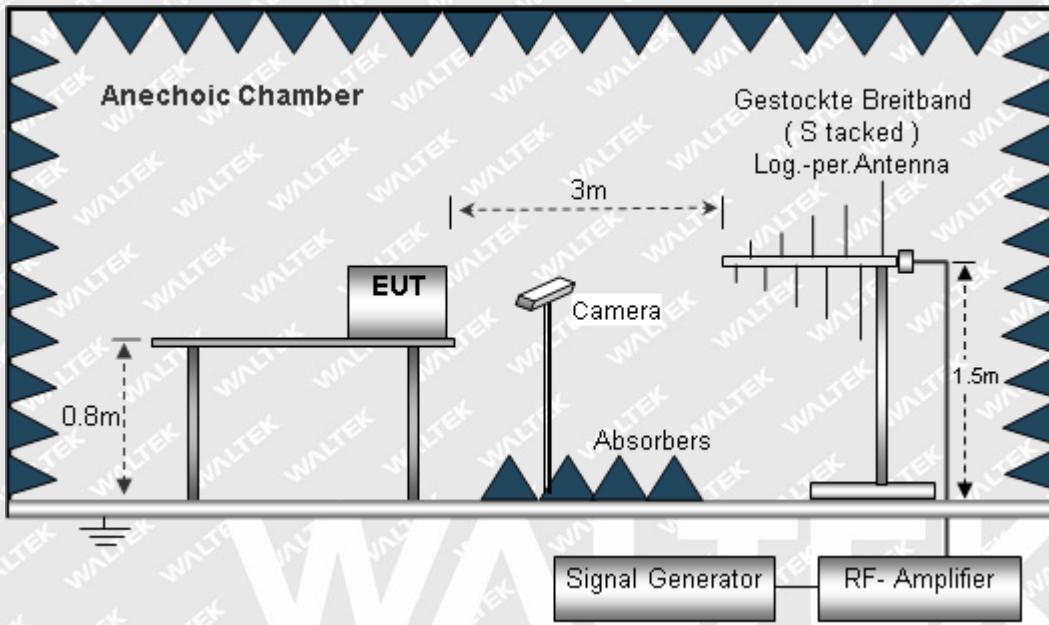


## 8. Radio Frequency Electromagnetic Field (R/S)

### 8.1 Test Procedure

Test is conducting under the description of EN 61000-4-3.

### 8.2 Test Setup Block Diagram



### 8.3 Test Performance

Performance Criterion:	Mode	Verdict
	TM1-TM3	A

Note: TM3 for CT,CR

### 8.4 Environmental Conditions

Temperature:	25°C
Relative Humidity:	50%
ATM Pressure:	1010 mbar

### 8.5 Continuous Radiated Disturbances Test Data

Frequency step: 1% of fundamental

Dwell time: 1 second

Modulation: AM by 1kHz sine wave with 80% modulation depth



Test mode		TM1-TM3							
Frequency Range(MHz)	Field (V/m)	Front		Rear		Left Side		Right Side	
		VERT	HORI	VERT	HORI	VERT	HORI	VERT	HORI
80-1000	3	A	A	A	A	A	A	A	A
1000-3000	3	A	A	A	A	A	A	A	A
3000-6000	3	A	A	A	A	A	A	A	A

Test Result: Pass

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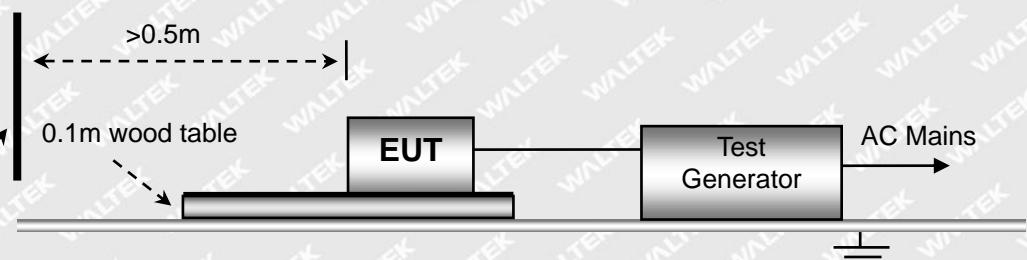
## 9. Fast Transients, Common Mode (EFT)

### 9.1 Test Procedure

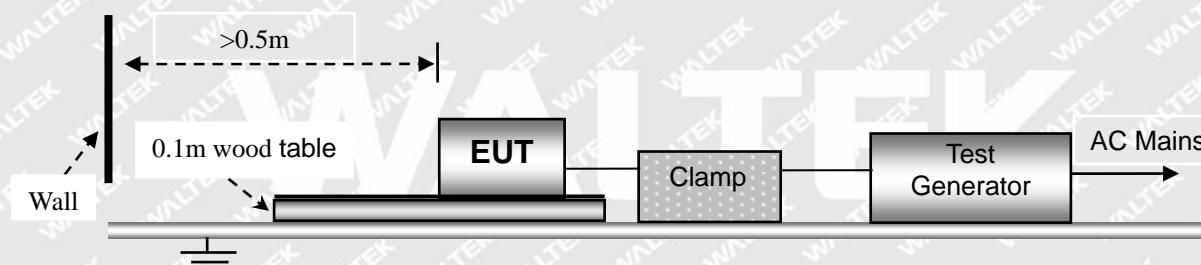
Test is conducting under the description of EN 61000-4-4.

### 9.2 Test Setup Block Diagram

For AC Mains or DC Ports:



For Signal or Telecommunication Ports:



### 9.3 Test Performance

Performance Criterion:	Mode	Verdict
	TM1-TM3	
Note: TM3 for TT,TR		

### 9.4 Environmental Conditions

Temperature:	25 °C
Relative Humidity:	50%
ATM Pressure:	1011 mbar

### 9.5 Electrical Fast Transients Test Data



Test Mode		TM1-TM3							
EN 61000-4-4 Test Line		Test Levels (kV)							
		+0.5	-0.5	+1.0	-1.0	+2.0	-2.0	+4.0	-4.0
AC Main Power port	L	A	A	A	A	/	/	/	/
	N	A	A	A	A	/	/	/	/
	PE	/	/	/	/	/	/	/	/
	L-N	A	A	A	A	/	/	/	/
	L-PE	/	/	/	/	/	/	/	/
	N-PE	/	/	/	/	/	/	/	/
	L-N-PE	/	/	/	/	/	/	/	/
Signal ports	/	/	/	/	/	/	/	/	/

Test Result: Pass



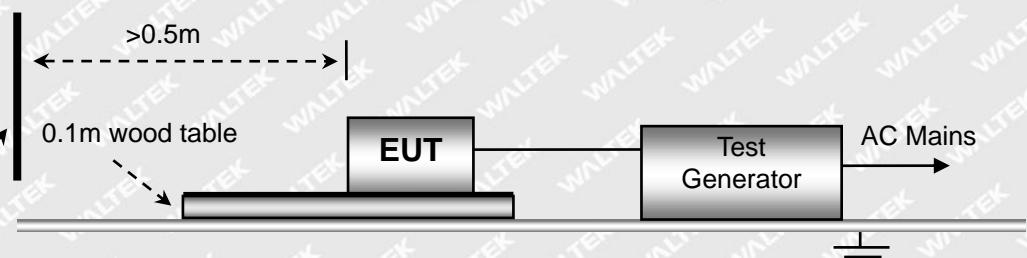
## 10. Surges

### 10.1 Test Procedure

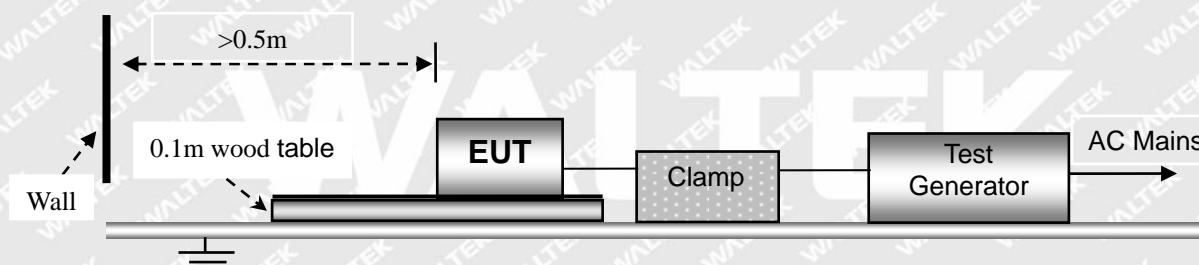
Test is conducting under the description of EN 61000-4-5.

### 10.2 Test Setup Block Diagram

For AC Mains or DC Ports:



For Signal or Telecommunication Ports:



### 10.3 Test Performance

Performance Criterion:	Mode	Verdict
	TM1-TM3	
Note: TM3 for TT,TR		

### 10.4 Environmental Conditions

Temperature:	25 °C
Relative Humidity:	50%
ATM Pressure:	1011 mbar

### 10.5 Surge Test Data



Test Mode	TM1-TM3			
Voltage	Poll	Path	Pass	Fail
0.5kV	±	L-N	A	/
1kV	±	L-N	A	/
2kV	±	L-N, L-PE, N-PE	/	/
4kV	±	L-N, L-PE, N-PE	/	/

Test Result: Pass



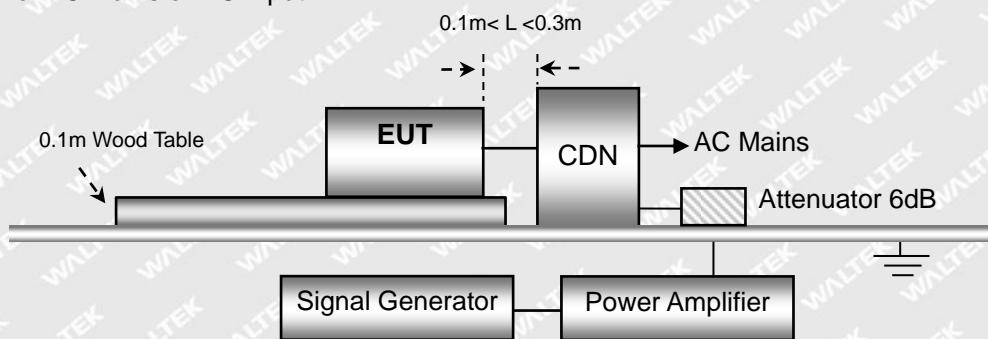
## 11. Radio Frequency, Common Mode (C/S)

### 11.1 Test Procedure

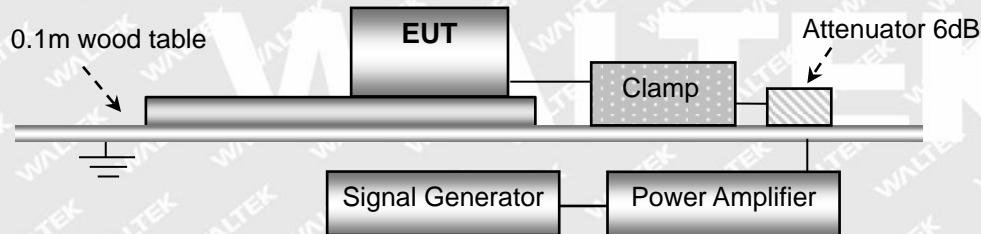
Test is conducting under the description of EN 61000-4-6.

### 11.2 Test Setup Block Diagram

For AC Mains or DC Input:



For Signal or Telecommunication Ports:



### 11.3 Test Performance

Performance Criterion:	Mode	Verdict
	TM1-TM3	A

Note: TM3 for CT,CR

### 11.4 Environmental Conditions

Temperature:	25 °C
Relative Humidity:	50%
ATM Pressure:	1011 mbar

### 11.5 Continuous Conducted Disturbances Test Data

Sweep frequency range: 150kHz~80MHz

Frequency step: 1% of fundamental

Dwell time: 1 second



Test Mode		TM1-TM3		
Level	Voltage (V) (rms, unmodulated)	Modulation:	Pass	Fail
1	1	AM 80%, 1kHz sinewave	/	/
2	3	AM 80%, 1kHz sinewave	A	/
3	10	AM 80%, 1kHz sinewave	/	/
X	Special	/	/	/

Test Result: Pass

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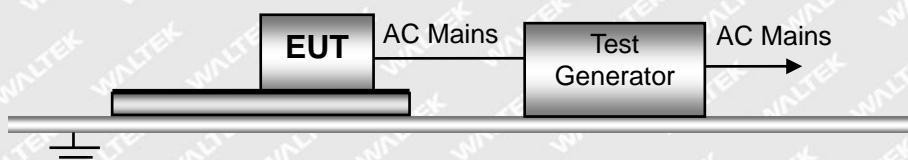


## 12. Voltage Dips and Interruptions

### 12.1 Test Procedure

Test is conducting under the description of EN 61000-4-11.

### 12.2 Test Setup Block Diagram



### 12.3 Test Performance

Performance Criterion:	Mode	Verdict
	TM1-TM3	B for voltage dip/ C for voltage interruption
Note: TM3 for TT,TR		

### 12.4 Environmental Conditions

Temperature:	25 °C
Relative Humidity:	50%
ATM Pressure:	1011 mbar

### 12.5 Voltage Dips And Interruptions Test Data

U: Voltage dips in % U<sub>T</sub> (U<sub>T</sub> is rated voltage for the EUT)

T: Test duration

Level	U	T	Phase Angle	N	Pass	Fail
1	100%	10ms	0/90/180/270	3	A	/
2	100%	20ms	0/90/180/270	3	B	/
3	30%	500ms	0/90/180/270	3	B	/
4	100%	5000ms	0/90/180/270	3	B	/

Test Result: Pass



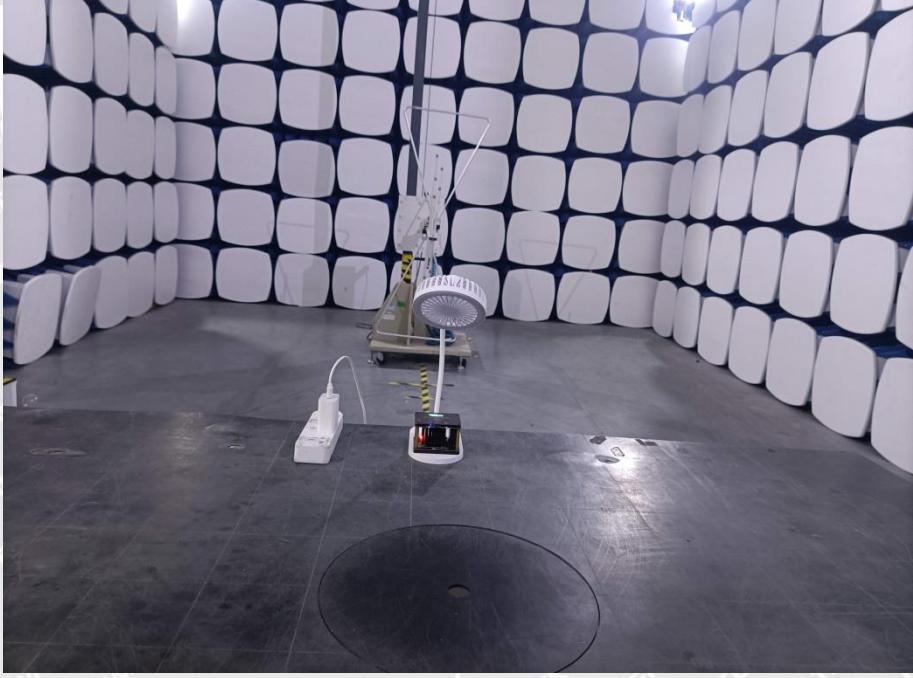
## EXHIBIT 1 - EUT PHOTOGRAPHS

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Please refer to "ANNEX".

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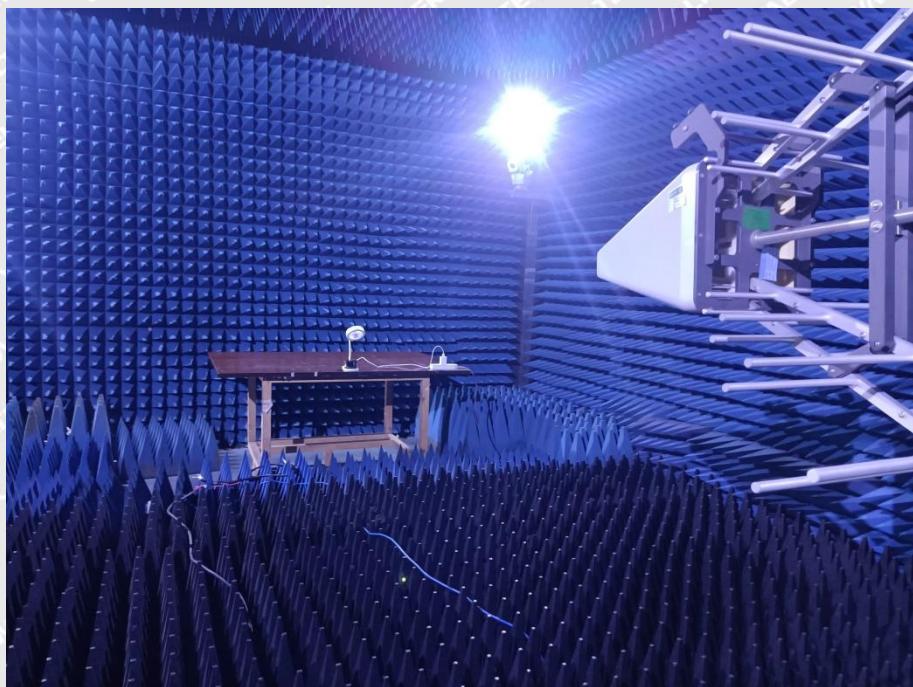
## EXHIBIT 2 - TEST SETUP PHOTOGRAPHS

<p><b>Conducted Emission Test Setup</b></p>	 A photograph showing a wooden workbench. On the left side, there is a piece of electronic equipment with a digital display and several buttons. A power strip is visible under the bench, connected to a red and black power outlet. A small white fan is placed on the right side of the bench.
<p><b>Radiation Emission Test View(30MHz to 1GHz)</b></p>	 A photograph of a radiation emission test chamber. The walls are covered in a grid of white, semi-circular acoustic panels. In the center of the room, there is a metal cart with various pieces of equipment, including a small fan and a power source. The floor is made of dark tiles.

<b>Harmonic/Flicker Test View</b>	
<b>EN 61000-4-2 Test View</b>	



**EN 61000-4-3 Test View**



**EN 61000-4-4/5/11 Test View**





**EN 61000-4-6 Test View**



\*\*\*\*\* END OF REPORT \*\*\*\*\*

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